

Search Notes

Application/Control No.

10/619,636

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under
Reexamination

CHAVEZ ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	201.01 387.01	8/28/2007	QN
455	415 417	8/28/2007	QN
709	200 206 238	8/28/07	QN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched: East, USPGPub, USPAT, EPO, JPO	8/28/07	QN
Inventor searched in PALM	8/28/07	QN